



TEST REPORT

Applicant : Samsung Electro-Mechanics Co., Ltd.
Address : 314, Maetan-3dong, Yeongtong-gu,
Suwon-si, Gyeonggi-do, 443-743 Korea

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Report No. RT12R-S0178-016-E-R

Date: Jan. 26, 2012

Sample Description : The following submitted sample(s) said to be:-

Name/Type of Product : Ceramic Chip Capacitor (MLCC)
Name of Material : Materials are ceramic & metal / Brown Ceramic, Silver Metal
Sample ID No. : RT12R-S0178-016
Item No. : MLCC A(X5R) TYPE (CL**A*****),
MLCC X(X6S) TYPE (CL**X*****)
Manufacturer/Vender : Samsung Electro-Mechanics Co., Ltd.

Sample received : Jan. 13, 2012
Testing Date : Jan. 13, 2012 ~ Jan. 20, 2012
Testing Environment : Temperature : (24 ± 2) °C, Humidity : (60 ± 5) % R.H.

Test Type : RoHS wet chemical analysis
Test Method(s) : Please see the following page(s).
Test Result(s) : Please see the following page(s).

* Note 1 : The test results presented in this report relate only to the object tested.

* Note 2 : This report shall not be reproduced except in full without the written approval of the testing laboratory.

* Note 3 : The item no. is assigned by client and indicated according to their requirement and guarantee letter.

Approved by,

Authorized by,

Jade Jang / Lab. Technical Manager

Bo Park / Lab. General Manager

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Date: Jan. 26, 2012

Sample ID No. : RT12R-S0178-016

Sample Description : Ceramic Chip Capacitor (MLCC)

Test Item	Unit	Test Method	MDL	Result
Cadmium (Cd)	mg/kg	With reference to IEC 62321 Edition 1.0 : 2008, by acid digestion and determined by ICP-OES	0.5	N.D.
Lead (Pb)	mg/kg		5	N.D.
Mercury (Hg)	mg/kg		2	N.D.
Hexavalent Chromium (Cr ⁶⁺) (For non-metal)	mg/kg	With reference to IEC 62321 Edition 1.0 : 2008, by alkaline digestion and determined by UV-VIS Spectrophotometer	1	N.D.
Polybrominated Biphenyl (PBBs)				
Monobromobiphenyl	mg/kg	With reference to IEC 62321 Edition 1.0 : 2008, by solvent extraction and determined by GC/MS	5	N.D.
Dibromobiphenyl	mg/kg		5	N.D.
Tribromobiphenyl	mg/kg		5	N.D.
Tetrabromobiphenyl	mg/kg		5	N.D.
Pentabromobiphenyl	mg/kg		5	N.D.
Hexabromobiphenyl	mg/kg		5	N.D.
Heptabromobiphenyl	mg/kg		5	N.D.
Octabromobiphenyl	mg/kg		5	N.D.
Nonabromobiphenyl	mg/kg		5	N.D.
Decabromobiphenyl	mg/kg		5	N.D.
Polybrominated Diphenyl Ether (PBDEs)				
Monobromodiphenyl ether	mg/kg	With reference to IEC 62321 Edition 1.0 : 2008, by solvent extraction and determined by GC/MS	5	N.D.
Dibromodiphenyl ether	mg/kg		5	N.D.
Tribromodiphenyl ether	mg/kg		5	N.D.
Tetrabromodiphenyl ether	mg/kg		5	N.D.
Pentabromodiphenyl ether	mg/kg		5	N.D.
Hexabromodiphenyl ether	mg/kg		5	N.D.
Heptabromodiphenyl ether	mg/kg		5	N.D.
Octabromodiphenyl ether	mg/kg		5	N.D.
Nonabromodiphenyl ether	mg/kg		5	N.D.
Decabromodiphenyl ether	mg/kg		5	N.D.

Tested by : Nikkie Lee, Leo Kim, Ellen Jung, Jessica Kang

Notes : mg/kg = ppm = parts per million
< = Less than
N.D. = Not detected (<MDL)
MDL = Method detection limit

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Report No. RT12R-S0178-016-E-R

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Date: Jan. 26, 2012

Sample ID No. : RT12R-S0178-016
Sample Description : Ceramic Chip Capacitor (MLCC)

Test Item	Unit	Test Method	MDL	Result
Bromine (Br)	mg/kg	With reference to EN 14582, by oxygen combustion with bomb and determined by IC	30	N.D.
Chlorine (Cl)	mg/kg	With reference to EN 14582, by oxygen combustion with bomb and determined by IC	30	N.D.
Antimony (Sb)	mg/kg	With reference to US EPA 3052, by acid digestion and determined by ICP-OES	2	N.D.
Phthalates				
Dibutyl phthalate (DBP)	mg/kg	With reference to US EPA 8061A, by solvent extraction and determined by GC/MS	50	N.D.
Di(2-ethylhexyl) phthalate (DEHP)	mg/kg	With reference to US EPA 8061A, by solvent extraction and determined by GC/MS	50	N.D.
Di-n-octyl phthalate (DNOP)	mg/kg	With reference to US EPA 8061A, by solvent extraction and determined by GC/MS	50	N.D.
Diisononyl phthalate* (DINP)	mg/kg	With reference to US EPA 8061A, by solvent extraction and determined by GC/MS	100	N.D.
Diisodecyl phthalate** (DIDP)	mg/kg	With reference to US EPA 8061A, by solvent extraction and determined by GC/MS	100	N.D.
Benzyl butyl phthalate (BBP)	mg/kg	With reference to US EPA 8061A, by solvent extraction and determined by GC/MS	50	N.D.
Diisobutyl phthalate (DIBP)	mg/kg	With reference to US EPA 8061A, by solvent extraction and determined by GC/MS	50	N.D.

Tested by : Nikkie Lee, Ellen Jung

Notes : mg/kg = ppm = parts per million
< = Less than
N.D. = Not detected (<MDL)
MDL = Method detection limit

* DINP include two types of phthalate (CAS No. 68515-48-0 and 28553-12-0).

** DIDP include two types of phthalate (CAS No. 68515-49-1 and 26761-40-0).

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Date: Jan. 26, 2012

Report No. RT12R-S0178-016-E-R

Sample ID No. : RT12R-S0178-016

Sample Description : Ceramic Chip Capacitor (MLCC)

* View of sample as received;-



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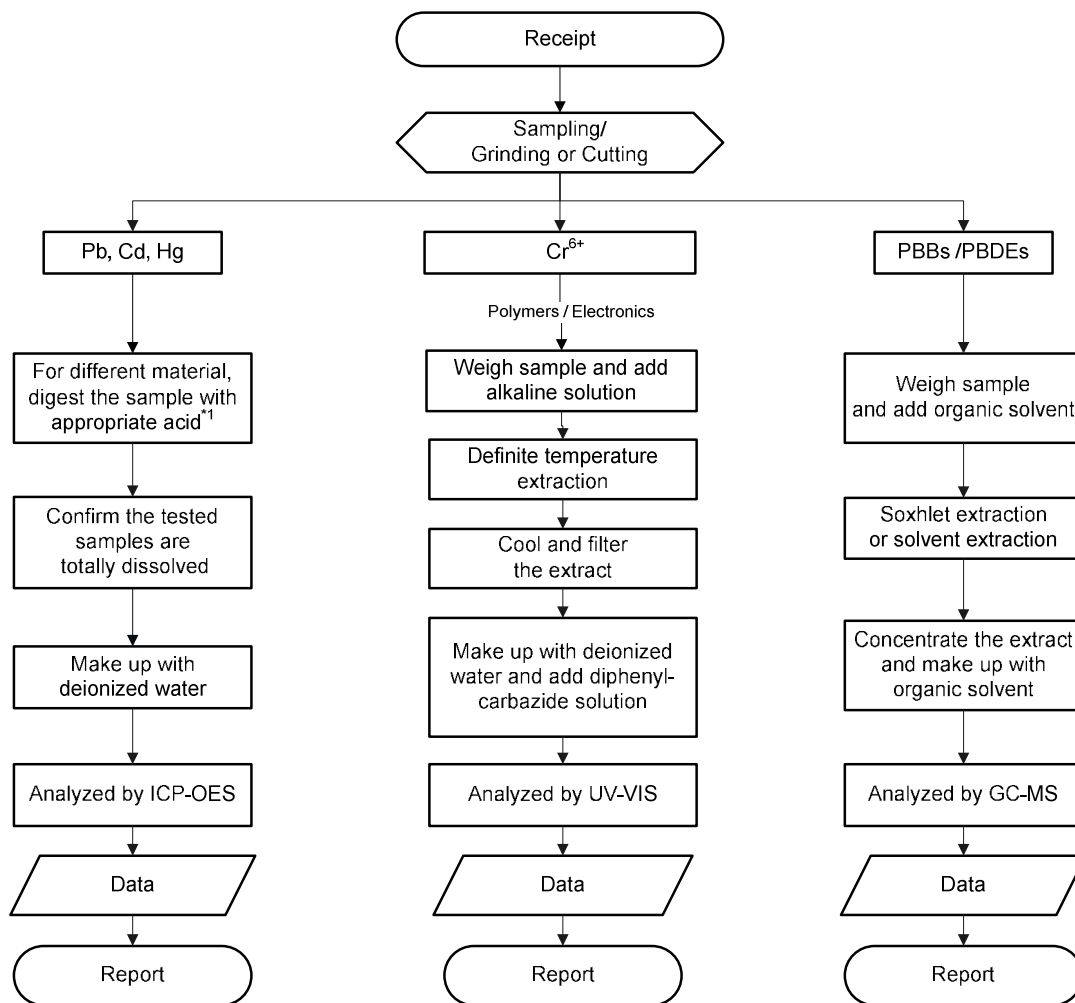
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Date: Jan. 26, 2012

Sample ID No. : RT12R-S0178-016

Sample Description : Ceramic Chip Capacitor (MLCC)

Flow Chart (IEC 62321 Edition 1.0 : 2008)



Remarks :

*1 : List of appropriate acid :

Material	Acid added for digestion
Polymers	HNO ₃ , HCl, HF, H ₂ O ₂ , H ₃ BO ₃
Metals	HNO ₃ , HCl, HF
Electronics	HNO ₃ , HCl, H ₂ O ₂ , HBF ₄

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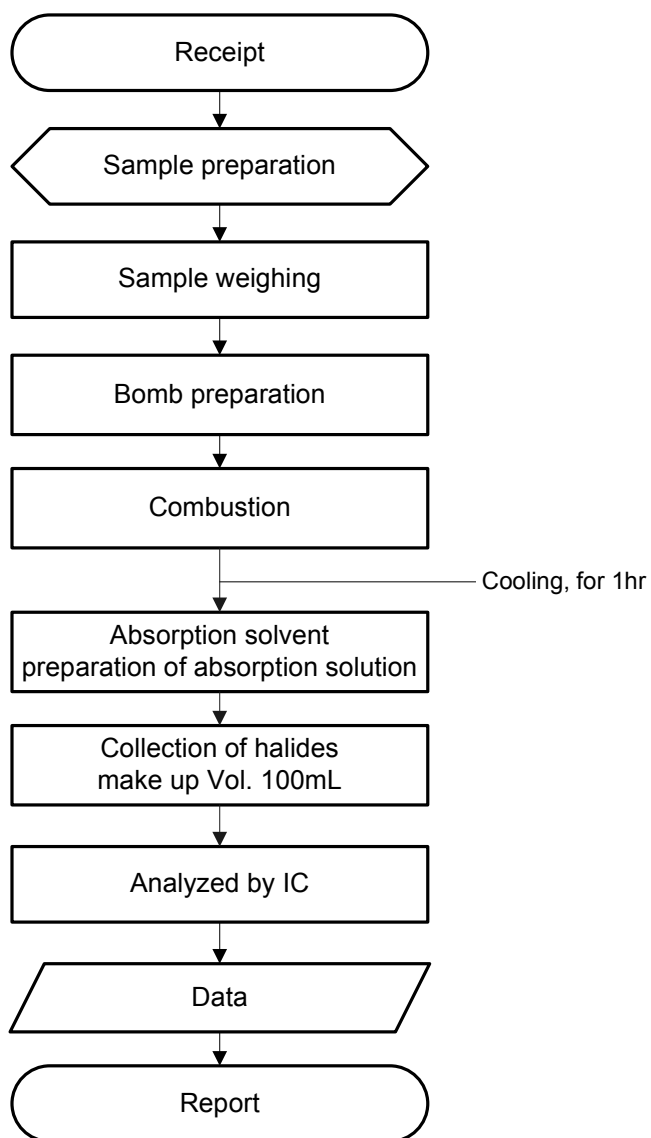
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Sample ID No. : RT12R-S0178-016

Sample Description : Ceramic Chip Capacitor (MLCC)

Flow Chart (Halogen)



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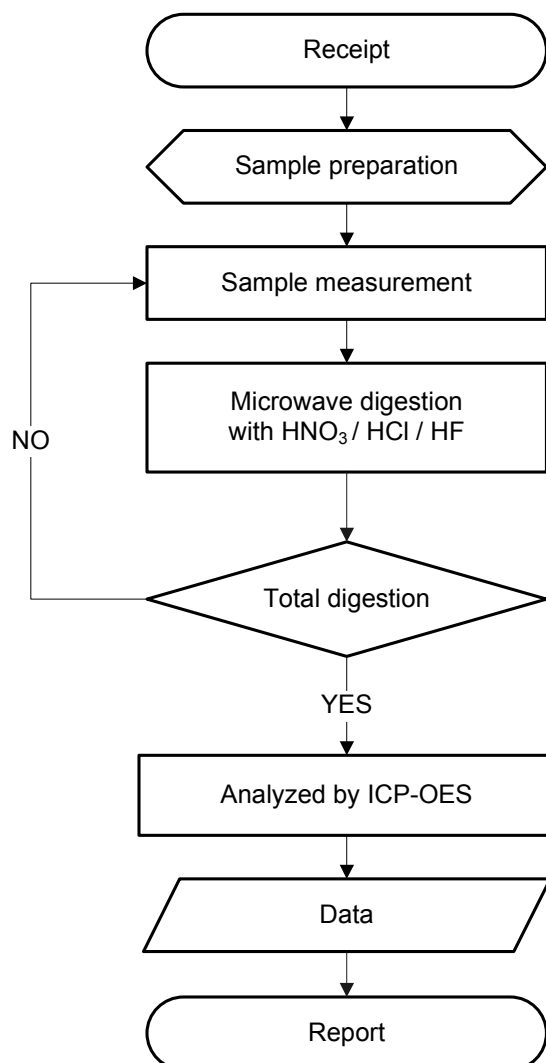
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Sample ID No. : RT12R-S0178-016

Sample Description : Ceramic Chip Capacitor (MLCC)

Flow Chart (Metal Testing)



** Remarks : The samples were dissolved totally by pre-conditioning method according to above flow chart.

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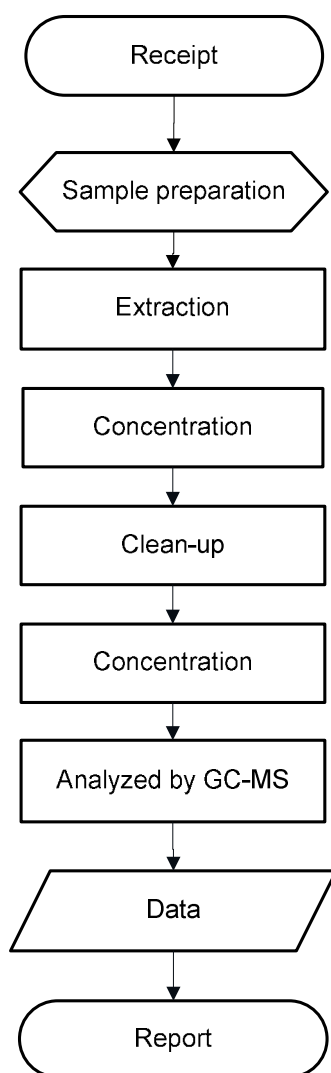
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Sample ID No. : RT12R-S0178-016

Sample Description : Ceramic Chip Capacitor (MLCC)

Flow Chart (Phthalates)



***** End of Report *****

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